

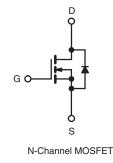
N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	200					
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.265				
Q _g (Max.) (nC)	16					
Q _{gs} (nC)	5					
Q _{gd} (nC)	8					
Configuration	Single					

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = RoHS f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- · Lead (Pb)-free Available





PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	200	V	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V	_C = 25 °C	- I _D -	10		
	VGS AL TO V	T _C = 100 °C		6.5	А	
Pulsed Drain Current ^a	I _{DM}	32	1			
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	36	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.2	A	
Repetitive Avalanche Energy ^a			E _{AR}	3.7	mJ	
Maximum Power Dissipation	T _C = 25	°C	PD	37	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s	3	-	300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
			_	1.1	N ⋅ m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 1.0 mH, $R_G = 25 \Omega$, $I_{AS} = 7.2 \text{ A}$ (see fig. 12). c. $I_{SD} \le 9.2 \text{ A}$, dl/dt $\le 110 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.



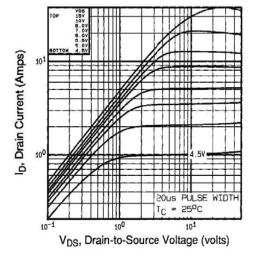
THERMAL RESISTANCE RA	TINGS								
PARAMETER	SYMBOL	TYP. MAX.			UNIT				
Maximum Junction-to-Ambient	R _{thJA}	- 65			°C/M				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 4.1				°C/W			
SPECIFICATIONS $T_J = 25 °C$,	unless otherw	vise noted							
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$			200	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I _D = 1 mA	-	0.13	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			2.0	-	4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 V$			-	-	± 100	nA	
	000	$V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =160 V, V _{GS} = 0 V, T _J = 150 °C			-	-	250	μA	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$ $I_D = 4.3 A^b$		-	0.265	-	Ω		
Forward Transconductance	9fs	V _{DS} = 50 V, I _D = 4.3 A ^b		2.3	-	-	S		
Dynamic						1	L		
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	560	-	pF		
Output Capacitance	C _{oss}			-	260	-			
Reverse Transfer Capacitance	C _{rss}			-	110	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg				-	-	16		
Gate-Source Charge	Q _{gs}			A, V _{DS} = 80 V, g. 6 and 13 ^b	-	-	4.4	nC	
Gate-Drain Charge	Q _{gd}		See ní	g. o and 15*	-	-	7.7		
Turn-On Delay Time	t _{d(on)}				-	8.8	-		
Rise Time	t _r			-	30	-	- ns		
Turn-Off Delay Time	t _{d(off)}			-	19	-			
Fall Time	t _f			-	20	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	Ls			-	7.5	-			
Drain-Source Body Diode Characteristic	cs						•		
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	10	-	A		
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	32		-	
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^\circ C, \ I_S = 7.2 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_{\rm J} = 25 \ ^{\circ}\text{C}, \ \text{I}_{\text{F}} = 9.2 \ \text{A}, \ \text{dI/dt} = 100 \ \text{A/}\mu\text{s}^{\text{b}}$		-	130	260	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.65	1.3	μC		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



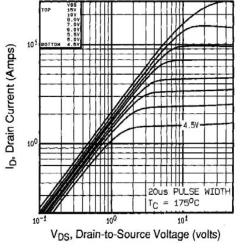


Fig. 2 - Typical Output Characteristics, T_C = 175 $^\circ C$

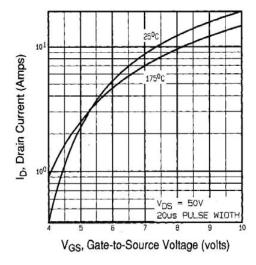


Fig. 3 - Typical Transfer Characteristics

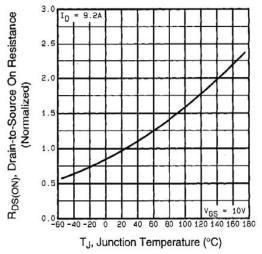


Fig. 4 - Normalized On-Resistance vs. Temperature



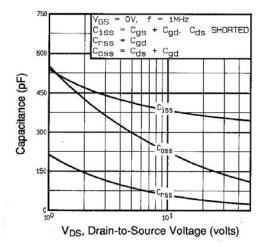


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

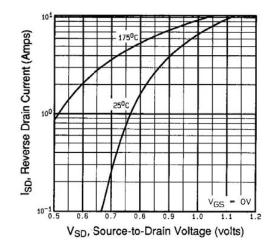


Fig. 7 - Typical Source-Drain Diode Forward Voltage

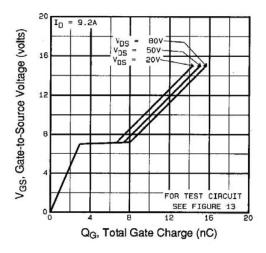


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

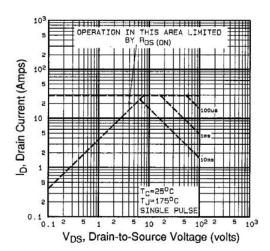


Fig. 5 - Fig. 8 - Maximum Safe Operating Area



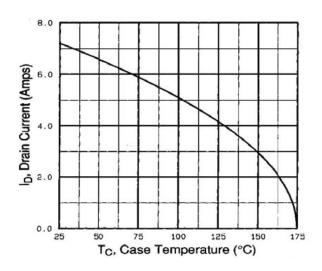


Fig. 9 - Maximum Drain Current vs. Case Temperature

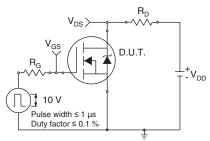


Fig. 10a - Switching Time Test Circuit

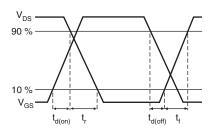
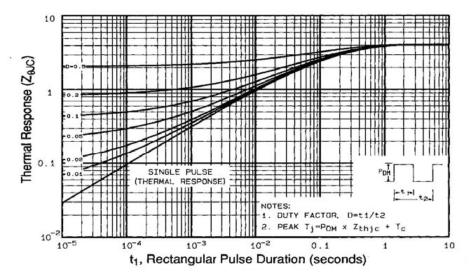
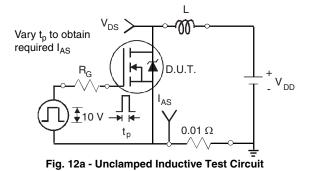


Fig. 10b - Switching Time Waveforms







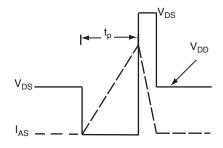
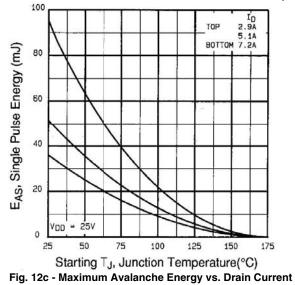


Fig. 12b - Unclamped Inductive Waveforms





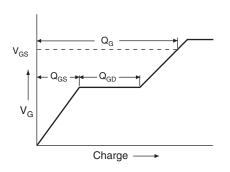
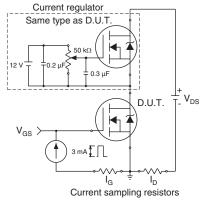
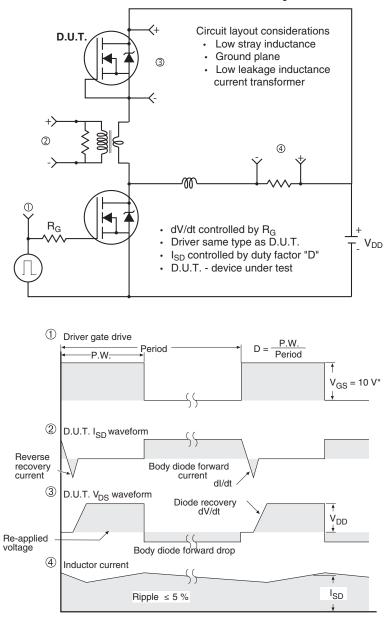


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel



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